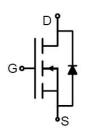


Feature

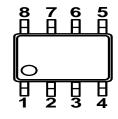
• 100V, 8A

$$\begin{split} &R_{\text{DS (ON)}} <& 25 \text{m}\,\Omega\,\text{@V}_{\text{GS}} =& 10 \text{V} \quad \text{(TYP:18m}\,\Omega\,\text{)} \\ &R_{\text{DS (ON)}} <& 38 \text{m}\,\Omega\,\text{@V}_{\text{GS}} =& 4.5 \text{V} \quad \text{(TYP:25 m}\,\Omega\,\text{)} \end{split}$$

- Split Gate Trench Technology
- Lead free product is acquired
- Excellent R_{DS (ON)} and Low Gate Charge



Schematic Diagram



SOP-8

Application

- PWM applications
- Load Switch
- Power management

Package Marking and Ordering Information

Device Marking Device		Device Package	Reel Size	Tape width	Quantity (PCS)
G250N01S	APG250N01S	SOP-8	13 inch	-	4000

ABSOLUTE MAXIMUM RATINGS (T_a=25℃ unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V _{DS}	100	V
Gate-Source Voltage	V _G S	±20	V
Continuous Drain Current (T _C =25℃)	I D	8	А
Continuous Drain Current (Tc =100℃)	I _D	5	Α
Pulsed Drain Current (1)	I _{DM}	40	Α
Single Pulsed Avalanche Energy (2)	Eas	10	mJ
Power Dissipation	PD	45	W
Thermal Resistance from Junction to Case	Rejc	2.5	°C/W
Junction Temperature	TJ	150	$^{\circ}$ C
Storage Temperature	T _{STG}	-55~ +150	$^{\circ}$ C



MOSFET ELECTRICAL CHARACTERISTICS(T_a=25℃ unless otherwise noted)

Parameter	Symbol	Test Condition	Min	Туре	Max	Unit
Static Characteristics						
Drain-source breakdown voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D =250μA	100	-	-	V
Zero gate voltage drain current	IDSS	V _{DS} =100V, V _{GS} = 0V	-	-	1	μΑ
Gate-body leakage current	I _{GSS}	V_{GS} = ± 20 V, V_{DS} = 0V	-	-	±100	nA
Gate threshold voltage ⁽³⁾	V _{GS(th)}	V _{DS} =V _{GS} , I _D =250μA	1.2	1.8	2.8	V
Drain-source on-resistance ⁽³⁾	P-a/	V _{GS} =10V, I _D = 6A	-	18	25	mΩ
Drain-source on-resistance	R _{DS(on)}	V _{GS} =4.5V, I _D = 5A	-	25	38	mΩ
Forward Threshold Voltage	G fs	V _{DS} =10V, I _D =6A	-	22	-	S
Gate Resistance	Rg	V _{DS} =V _{GS} =0V, f =1MHz	-	1.62	-	Ω
Dynamic characteristics	·					
Input Capacitance	C _{iss}	V _{DS} =50V, V _{GS} =0V, f =1MHz	-	822	-	pF
Output Capacitance	Coss		-	310	-	
Reverse Transfer Capacitance	C _{rss}	_	-	23.5	-	
Switching characteristics	·					
Turn-on delay time	t _{d(on)}		-	15	-	
Turn-on rise time	t _r	V_{DD} =50V, I_D =6A, V_{GS} =10V, R_G =3 Ω	-	3.2	-	ns
Turn-off delay time	t _{d(off)}		-	30	-	
Turn-off fall time	t _f	tr		7.6	-	
Total Gate Charge	Qg	\/DC_E0\/ ID_CA	-	22.7	-	nC
Gate-Source Charge	Qgs	VDS=50V, ID=6A,	-	6.2	-	
Gate-Drain Charge	Qgd	- VGS=10V	-	5.3	-	
Reverse Recovery Chrage	Qrr	I _F =6A, di/dt=100A/us		59		nC
Reverse Recovery Time	Trr	I _F =6A, di/dt=100A/us		45		ns
Source-Drain Diode characteristics						
Diode Forward voltage ⁽³⁾	V _{DS}	V _{GS} =0V, I _S =6A	-	-	1.2	V
Diode Forward current ⁽⁴⁾	Is		-	-	8	Α

Notes:

- 1. Repetitive Rating: pulse width limited by maximum junction temperature
- 2. EAS Condition: $T_J=25^{\circ}C$, $V_{DD}=50V$, $R_G=25^{\circ}\Omega$,L=0.5Mh
- 3. Pulse Test: pulse width≤300µs, duty cycle≤2%
- 4. Surface Mounted on FR4 Board,t≤10 sec



Typical Performance Characteristics

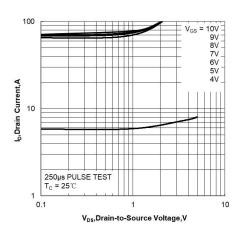


Figure 1. Output Characteristics

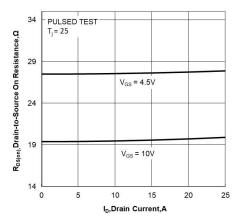


Figure 3. Drain-to-Source On Resistance vs Drain Current

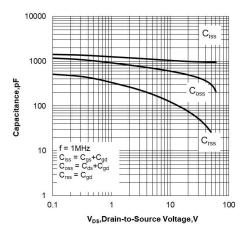


Figure 5. Capacitance Characteristics

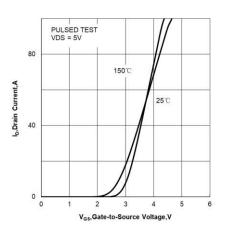


Figure 2. Transfer Characteristics

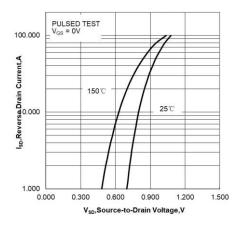


Figure 4. Body Diode Forward Voltage vs Source Current and Temperature

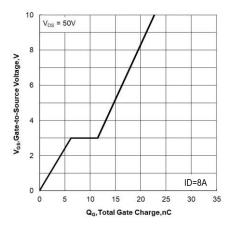


Figure 6. Gate Charge Characteristics



DATA SHEET

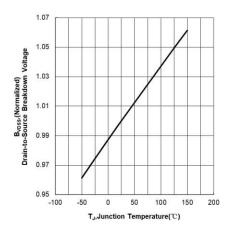


Figure 7. Normalized Breakdown Voltage vs Junction Temperature

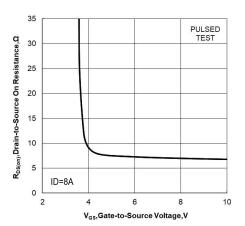


Figure 9. Drain-to-Source On Resistance vs Gate
Voltage and Drain Current

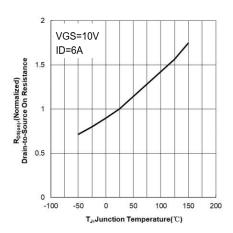


Figure 8. Normalized On Resistance vs

Junction Temperature

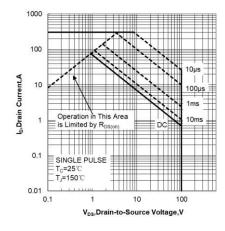


Figure 10. Maximum Safe Operating Area

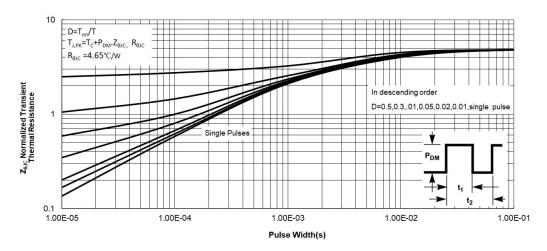
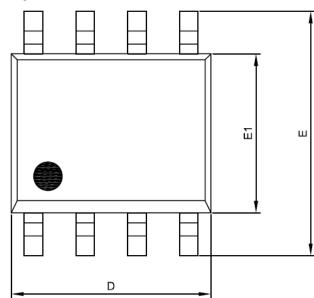


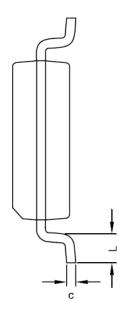
Figure 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

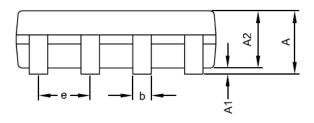


Package Dimensions

SOP-8







Symbol	Dimensions In Millimeters			
Symbol	MIN.	MAX.		
Α	1.35	1.75		
A1	0.00	0.25		
A2	1.15	1.50		
D	4.80	5.00		
E	5.80	6.20		
E1	3.80	4.00		
С	0.19	0.27		
b	0.33	0.53		
е	1.27 BSC			
L	0.40	1.27		

APG250N01S N-Channel Enhancement Mosfet



Revision History

Revision	Release	Remark
V1.0	2022/12/15	Initial Release

Disclaimer

The information given in this document describes the independent performance of the product, but similar performance is not guaranteed under other working conditions, and cannot be guaranteed when installed with other products or equipment. To achieve the required performance of the product in actual scenarios, the customer should conduct a complete application test to assess the functionality of the product.

Allpower assumes no responsibility for equipment failures result from using products at values that exceed the ratings, operating conditions, or other parameters listed in the product specifications.

The product described in this specification is not applicable for aerospace or other applications which requires high reliability. Customers using or selling these products for use in medical, life-saving, or life-sustaining applications do so at their own risk and agree to fully indemnify.

Due to product or technical improvements, the information described or contained herein may be changed without prior notice.